

Notice of References Cited	Application/Control No. 09/800,851	Applicant(s)/Patent Under Reexamination HUTTON ET AL.	
	Examiner Albert Wang	Art Unit 2115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,239,603	05-2001	Ukei et al.	324/763
	B	US-5,818,250	10-1998	Yeung et al.	324/763
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IEEE Std 1149.1-1990, "IEEE Standard Test Access Port and Boundary-Scan Architecture", (includes IEEE Std 1149.1a-1993), 1993.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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